MAY 0 4 2005 5		PTO/SB/21 (09-04)
TRANSMITTAL	Application Number Filing Date	10/616,896 July 9, 2003
FORM	First Named Inventor Art Unit	Quake, Stephen R. 2878
(to be usea for all correspondence after initial filin	Examiner Name	Patrick J. Lee
Total Number of Pages in This Submission	Attorney Docket Number	020859-001310US
	ENCLOSURES (Check all t	hat annivi
Fee Transmittal Form Fee Attached Amendment/Reply After Final Affidavits/declaration(s) Extension of Time Request Express Abandonment Request Supplemental Information Disclosure Statement Certified Copy of Priority Document(s) Reply to Missing Parts/ Incomplete Application Reply to Missing Parts under 37 CFR 1.52 or 1.53	Drawing(s) Licensing-related Papers Petition Petition to Convert to a Provisional Application Power of Attorney, Revocation Change of Correspondence A Terminal Disclaimer Request for Refund CD, Number of CD(s) Landscape Table on Ci Remarks The Commissioner in Account 20-1430.	After Allowance Communication to TC Appeal Communication to Board of Appeals and Interferences Appeal Communication to TC (Appeal Notice, Brief, Reply Brief) Proprietary Information Status Letter Other Enclosure(s) (please identify below): Return Postcard PTO/SB/08A & PTO/SB/08B Reference Copies Sauthorized to charge any additional fees to Deposit
Firm Name	TURE OF APPLICANT, ATTOR	RNEY, OR AGENT
Townsend and Towns	send and Crew LLP	····
Printed name	$\overline{\qquad}$	
Pate Richard T. Ogawa	Reg.	No. 37,692

CERTIFICATE OF TRANSMISSION/MAILING I hereby certify that this correspondence is being deposited with the United States Postal Service with sufficient postage as first class mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450 on the date shown below. Signature Tiffany Wu Typed or printed name

Attorney Docket No.: 020859-001310US Client Reference No.: 3650

By:_______

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of:

Stephen R. Quake et al.

Application No.: 10/616,896

Filed: July 9, 2003

For: IMPROVED METHOD AND SYSTEM FOR SCANNING APERTURELESS FLUORESCENCE

MICROSCOPE

Examiner: Patrick J. Lee

Art Unit: 2878

SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR §1.97 and §1.98

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

The references cited on attached form PTO/SB/08A and PTO/SB/08B are being called to the attention of the Examiner. This IDS is submitted after the Notice of Allowance has been issue d. We are submitting these references and bringing them to the attention of the Examiner out of an abundance of caution, although they may already be cumulative of information of record or not material to patentability. Applicants understand that the references may not be entered, but request that the Examiner consider these references and place them in the application file wrapper.

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As provided for by 37 CFR 1.97(g) and (h), no inference should be made that the information and references cited are prior art merely because they are in this statement and no representation is being made that a search has been conducted or that this statement encompasses all the possible relevant information.

Respectfully submitted,

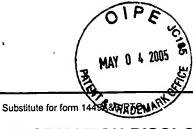
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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(use as many sheets as necessary)

Sheet

	Complete if Known
Application Number	10/616,896
Filing Date	July 9, 2003
First Named Inventor	Quake, Stephen R.
Art Unit	2878
Examiner Name	Patrick J. Lee
Attorney Docket Number	020859-001310US

U.S. PATENT DOCUMENTS+					
		Document Number			
Examiner Initials*	Cite No.1	Number Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
	1	US 6,850,323	02-01-2005	Anderson	
					. 8

				FOREIGN PA	TENT DOCUME	NTS		
Examiner	Cite	Foreign Patent Document			Publication Date	Name of Patentee or	Pages, Columns, Lines, Where Relevant	
Initials*	No.¹	Country Code ³	Number ⁴	Kind Code ⁵ (if known)	MM-DD-YYYY	Applicant of Cited Document	Passages or Relevant Figures Appear	T ⁶
			- <u></u> -					

NON PATENT LITERATURE DOCUMENTS				
Examiner Initials *	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T²	
	2	GERTON et al., Tip-Enhanced Fluorescence Microcopy at 10 Nanometer Resolution, Department of Applied Physics, CALTECH, MC 128-95, Pasadena, CA, 2004.		
	3	KAWATA et al., Feasibility of Molecular-Resolution Fluorescence near-field Microscopy using Multi- Photon Absorption and Field Enhancement near a sharp tip, Journal of Applied Physics, Volume 85, Number 3, 1999.		
	4	SANCHEZ et al, Near-Field Fluorescence Microscopy Based on Two-Photon Excitation with Metal Tips, Physical Review Letters, Volume 82, Number 20, 1999.		

Examiner Signature	Date Considered	

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). Applicant is to place a check mark here if English language Translation is attached.